## Notice of References Cited Application/Control No. O9/871,282 Examiner Mike Tomaszewski Applicant(s)/Patent Under Reexamination YU ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*	-	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,429,792 A	02-1984	Machbitz, Jacob M.	206/531
*	В	US-D281,176 S	10-1985	Sukovich, Suzanne B.	D20/18
*	С	US-4,617,557 A	10-1986	Gordon, Richard E.	340/309.7
*	D	US-4,762,230 A	08-1988	Croce, Carlo P.	206/469
*	E	US-5,014,851 A	05-1991	Wick, John J.	206/539
*	F	US-5,788,079 A	08-1998	Bouthiette, Michel	206/534
*	G	US-5,845,255 A	12-1998	Mayaud, Christian	705/3
*	Н	US-6,283,761 B1	09-2001	Joao, Raymond Anthony	434/236
*	1	US-6,371,297 B1	04-2002	Cha, Young Dae	206/534
*	J	US-6,493,427 B1	12-2002	Kobylevsky et al.	379/67.1
*	К	US-6,981,592 B2	01-2006	Siegel, Todd	206/538
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т				V	

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.